TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74VHC27F,TC74VHC27FN,TC74VHC27FT

#### Triple 3-Input NOR Gate

The TC74VHC27 is an advanced high speed CMOS 3-INPUT NOR GATE fabricated with silicon gate C<sup>2</sup>MOS technology.

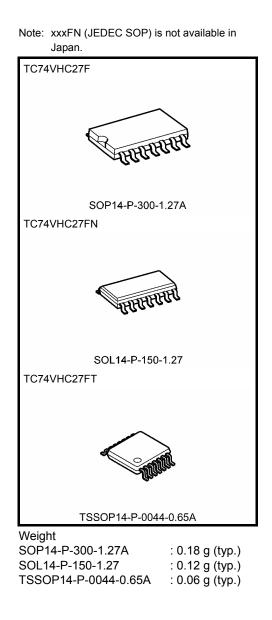
It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The internal circuit is composed of 3 stages including a buffer output, which provide high noise immunity and stable output.

An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

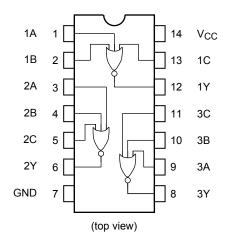
#### Features

- High speed:  $t_{pd}$  = 4.1 ns (typ.) at V<sub>CC</sub> = 5 V
- Low power dissipation:  $I_{\rm CC}$  = 2  $\mu A$  (max) at Ta = 25°C
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range:  $V_{CC (opr)} = 2 \text{ to } 5.5 \text{ V}$
- Pin and function compatible with 74ALS27

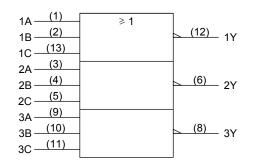


# <u>TOSHIBA</u>

### **Pin Assignment**



#### **IEC Logic Symbol**



#### **Truth Table**

| А | В | С | Y |
|---|---|---|---|
| Н | Х | Х | L |
| Х | Н | Х | L |
| Х | Х | Н | L |
| L | L | L | Н |

X: Don't care

# Absolute Maximum Ratings (Note)

| Characteristics                    | Symbol           | Rating                        | Unit |
|------------------------------------|------------------|-------------------------------|------|
| Supply voltage range               | V <sub>CC</sub>  | -0.5 to 7.0                   | V    |
| DC input voltage                   | V <sub>IN</sub>  | -0.5 to 7.0                   | V    |
| DC output voltage                  | V <sub>OUT</sub> | -0.5 to V <sub>CC</sub> + 0.5 | V    |
| Input diode current                | I <sub>IK</sub>  | -20                           | mA   |
| Output diode current               | I <sub>OK</sub>  | ±20                           | mA   |
| DC output current                  | IOUT             | ±25                           | mA   |
| DC V <sub>CC</sub> /ground current | ICC              | ±50                           | mA   |
| Power dissipation                  | PD               | 180                           | mW   |
| Storage temperature                | T <sub>stg</sub> | –65 to 150                    | °C   |

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

# **Operating Ranges (Note)**

| Characteristics          | Symbol           | Rating                              | Unit |  |
|--------------------------|------------------|-------------------------------------|------|--|
| Supply voltage           | V <sub>CC</sub>  | 2.0 to 5.5                          | V    |  |
| Input voltage            | V <sub>IN</sub>  | 0 to 5.5                            | V    |  |
| Output voltage           | V <sub>OUT</sub> | 0 to V <sub>CC</sub>                | V    |  |
| Operating temperature    | T <sub>opr</sub> | -40 to 85                           | °C   |  |
| Input rise and fall time | dt/dv            | 0 to 100 (V_{CC} = 3.3 $\pm$ 0.3 V) | ns/V |  |
|                          | uvuv             | 0 to 20 (V_{CC} = 5 $\pm$ 0.5 V)    |      |  |

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

# **Electrical Characteristics**

#### **DC Characteristics**

| Characteristics             | Characteristics Symbol |   | Test Condition           |               |                       | Ta = 25°C |                       |                       | Ta =<br>-40 to 85°C |    |
|-----------------------------|------------------------|---|--------------------------|---------------|-----------------------|-----------|-----------------------|-----------------------|---------------------|----|
|                             |                        |   |                          | $V_{CC}(V)$   | Min                   | Тур.      | Max                   | Min                   | Max                 |    |
| High-level input            |                        | _   |                          | 2.0           | 1.50                  | _         |                       | 1.50                  | _                   | v  |
| voltage                     | VIH                    |   |                          | 3.0 to<br>5.5 | V <sub>CC</sub> × 0.7 | _         | —                     | V <sub>CC</sub> × 0.7 | _                   |    |
| Low-level input             |                        |   |                          | 2.0           | _                     | _         | 0.50                  | _                     | 0.50                |    |
| voltage                     |                        | —   |                          | 3.0 to<br>5.5 | —                     | _         | V <sub>CC</sub> × 0.3 | _                     | $V_{CC} \times 0.3$ | V  |
|                             | Vон                    |   |                          | 2.0           | 1.9                   | 2.0       | _                     | 1.9                   | _                   |    |
|                             |                        | $V_{IN} = V_{IL}$                                       | I <sub>OH</sub> = -50 μA | 3.0           | 2.9                   | 3.0       | —                     | 2.9                   | —                   |    |
| High-level output voltage   |                        |   |                          | 4.5           | 4.4                   | 4.5       |                       | 4.4                   | _                   | V  |
| Ŭ                           |                        |   | I <sub>OH</sub> = -4 mA  | 3.0           | 2.58                  | —         | —                     | 2.48                  | —                   |    |
|                             |                        |   | $I_{OH} = -8 \text{ mA}$ | 4.5           | 3.94                  | _         |                       | 3.80                  | _                   |    |
|                             | V <sub>OL</sub>        | V <sub>IN</sub><br>= V <sub>IH</sub> or V <sub>IL</sub> |                          | 2.0           | —                     | 0.0       | 0.1                   | —                     | 0.1                 |    |
|                             |                        |   | $I_{OL} = 50 \ \mu A$    | 3.0           | —                     | 0.0       | 0.1                   | —                     | 0.1                 |    |
| Low-level output<br>voltage |                        |   |                          | 4.5           | —                     | 0.0       | 0.1                   | —                     | 0.1                 | V  |
|                             |                        |   | $I_{OL} = 4 \text{ mA}$  | 3.0           | —                     | —         | 0.36                  | —                     | 0.44                |    |
|                             |                        |   | $I_{OL} = 8 \text{ mA}$  | 4.5           | —                     | _         | 0.36                  | —                     | 0.44                |    |
| Input leakage<br>current    | I <sub>IN</sub>        | V <sub>IN</sub> = 5.5 V or GND                          |                          | 0 to 5.5      | —                     |           | ±0.1                  | _                     | ±1.0                | μA |
| Quiescent supply current    | ICC                    | V <sub>IN</sub> = V <sub>CC</sub> or GND                |                          | 5.5           |                       |           | 2.0                   | _                     | 20.0                | μA |

## AC Characteristics (input: tr = tf = 3 ns)

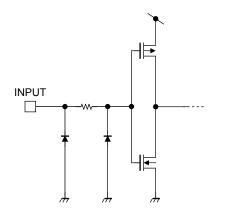
| Characteristics               | Symbol                               | Te | Test Condition      |                     | Ta = 25°C |      |      | Ta =<br>-40 to 85°C |      | Unit |
|-------------------------------|--------------------------------------|----|---------------------|---------------------|-----------|------|------|---------------------|------|------|
|                               | -,                                   |    | V <sub>CC</sub> (V) | C <sub>L</sub> (pF) | Min       | Тур. | Max  | Min                 | Max  |      |
| Propagation delay<br>time     | <sup>t</sup> pLH<br>t <sub>pHL</sub> | _  | $3.3\pm0.3$         | 15                  | _         | 6.2  | 8.8  | 1.0                 | 10.5 | - ns |
|                               |                                      |    |                     | 50                  | _         | 8.7  | 12.3 | 1.0                 | 14.0 |      |
|                               |                                      |    | $5.0\pm0.5$         | 15                  | _         | 4.1  | 5.9  | 1.0                 | 7.0  |      |
|                               |                                      |    |                     | 50                  | _         | 5.6  | 7.9  | 1.0                 | 9.0  |      |
| Input capacitance             | C <sub>IN</sub>                      |    | _                   |                     | _         | 4    | 10   | _                   | 10   | pF   |
| Power dissipation capacitance | C <sub>PD</sub>                      |    |                     | (Note)              | _         | 20   | _    |                     | _    | pF   |

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/3$  (per gate)

#### Input Equivalent Circuit

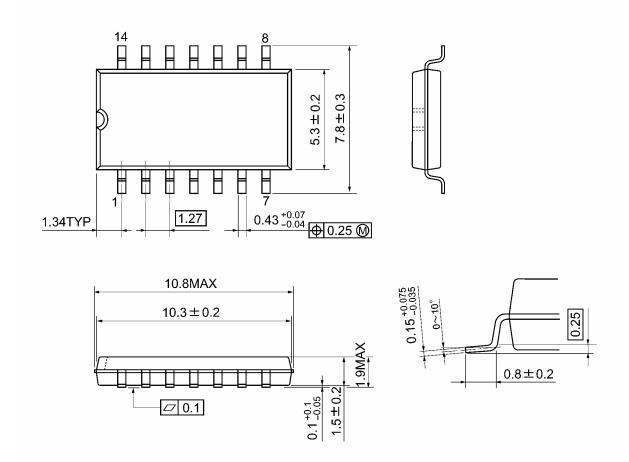




## **Package Dimensions**

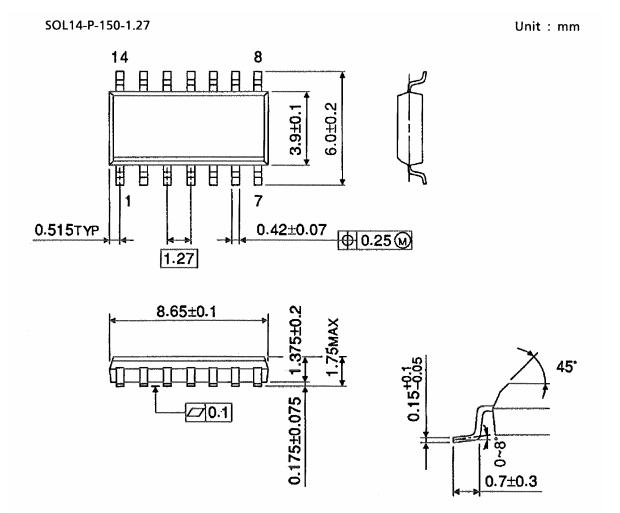
SOP14-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

# Package Dimensions (Note)



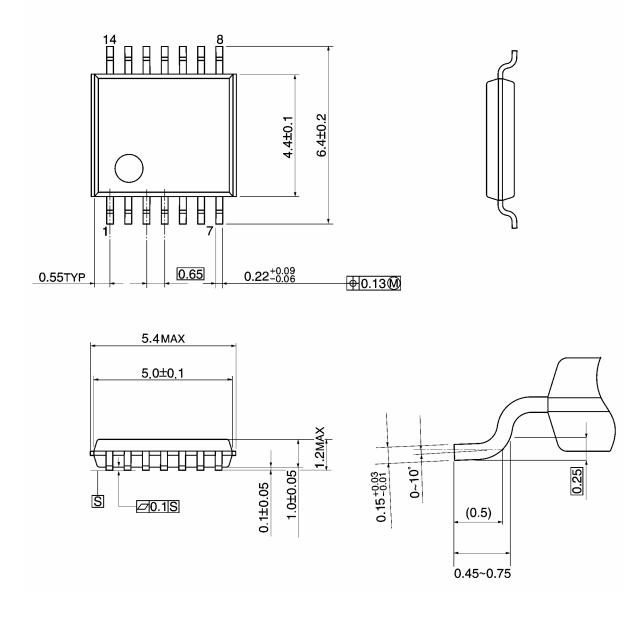
Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

# Package Dimensions

TSSOP14-P-0044-0.65A

Unit: mm



Weight: 0.06 g (typ.)

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20070701-EN GENERAL

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